Product Document





TMD3702VC

Narrow ALS, Color and Proximity Sensor Module

General Description

The TMD3702VC features proximity detection, color sense (RGBC+IR), and digital ambient light sensing (ALS). The extremely narrow 1.44mm module incorporates an IR VCSEL and factory calibrated VCSEL driver. The proximity detection feature provides object detection (e.g. mobile device screen to user's ear) by photodiode detection of reflected IR energy (sourced by the integrated VCSEL). Detect/release events are interrupt driven, and occur when proximity result crosses upper and/or lower threshold settings. The proximity engine features a wide range offset adjustment to compensate for unwanted IR energy reflection at the sensor. Proximity results are further improved by automatic ambient light subtraction. The color photodiodes have UV and IR blocking filters and dedicated data converters producing 16-bit data. This architecture allows applications to accurately measure ambient light which enables devices to calculate illuminance and color temperature to control display backlight and chromaticity.

Ordering Information and Content Guide appear at end of datasheet.

Key Benefits & Features

The benefits and features of TMD3702VC, Narrow ALS, Color and Proximity Sensor Module are listed below:

Figure 1: Added Value of Using TMD3702VC

Benefits	Features
Single device integrated optical solution	 ALS + color + proximity 1.44mm x 2.84mm x 0.65mm module ±48° field of view Integrated 940nm IR VCSEL Power management features I²C fast mode interface compatible
Accurate ambient light sensing	 5 channels (RGBC + IR) UV / IR blocking filters Programmable gain and integration time
Reduced power consumption	 1.8V power supply with 1.8V I²C bus Sleep mode



Applications

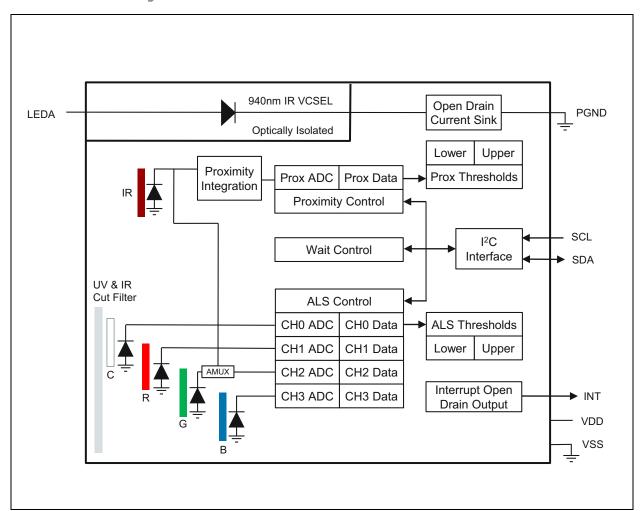
The TMD3702VC applications include:

- Ambient light sensing
- · Proximity sensing
- Mobile phone touch screen disable
- Color temperature measurement to assist display, backlight, camera, and flash control

Block Diagram

The functional blocks of this device are shown below:

Figure 2: TMD3702VC Block Diagram



Page 2Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Pin Assignment

Figure 3: Pin Diagram

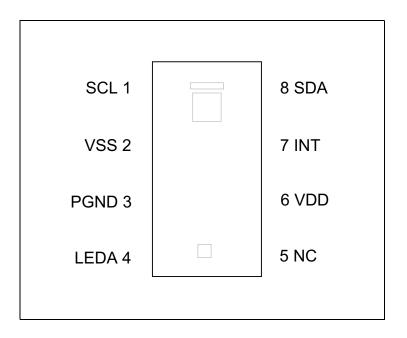


Figure 4: Pin Description

Pin Number	Pin Name	Description
1	SCL	I ² C serial clock input terminal
2	VSS	Ground. All voltages are referenced to VSS/PGND and both pins must
3	PGND	be connected to ground.
4	LEDA	VCSEL anode
5	NC	No connect. No internal electrical connection. For improved device ESD protection, connect to ground.
6	VDD	Supply voltage (1.8V)
7	INT	Interrupt. Open drain output (active low)
8	SDA	I ² C serial data I/O terminal

Datasheet, PublicPage 3[v2-00] 2023-Mar-14Document Feedback



Absolute Maximum Ratings

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other condition beyond those indicated under Electrical Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 5:
Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Units	Comments
VDD	Supply voltage to ground	-0.3 2.0		V	
LEDA	VCSEL voltage to PGND	-0.3	3.6	V	
V _{IO}	Digital I/O terminal voltage	-0.3	3.6	V	
I _{IO}	Digital output terminal current	-1	20	mA	
I _{VCSEL}	VCSEL current		30	mA	
I _{SCR}	Input current (latch-up immunity)	± 100		mA	Class II JEDEC JESD78D
ESD _{HBM}	HBM electrostatic discharge	± 2000		V	JS-001-2014
ESD _{CDM}	CDM electrostatic discharge	± 5	500	V	JEDEC JESD22-C101F
T _{STRG}	Storage temperature range	-40	85	°C	
T _{BODY}	Package body temperature		260 °C		IPC/JEDEC J-STD-020 The reflow peak soldering temperature (body temperature) is specified according to IPC/JEDEC J-STD-020 "Moisture/Reflow Sensitivity Classification for Non-hermetic Solid State Surface Mount Devices."
RH _{NC}	Relative humidity (non-condensing)	5	85	%	
P _{DISS}	Power dissipation		200	mW	Average power dissipation over a 1 second period

Page 4Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Electrical Characteristics

All limits are guaranteed. The parameters with min and max values are guaranteed with production tests or SQC (Statistical Quality Control) methods.

Figure 6: **Recommended Operating Conditions**

Symbol	Parameter	Min	Тур	Max	Units
VDD	Supply voltage	1.7	1.8	2.0	V
V _{LEDA}	Supply voltage to VCSEL anode (PLDRIVE = 19mA)	3.0	3.3	3.6	V
* LEDA	Supply voltage to VCSEL anode (PLDRIVE = 14mA)	2.8	3.3	3.6	V
P _{DISS}	Average power dissipation ⁽¹⁾			100	mW
T _A	Operating ambient temperature	-30		85	°C

Note(s):

Datasheet, Public Page 5 [v2-00] 2023-Mar-14 Document Feedback

^{1.} Power dissipation averaged over 1 second period.



Figure 7: Operating Characteristics ($V_{DD} = 1.8V$, $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{OSC}	Oscillator frequency			8.1		MHz
		Active ALS State (PON=AEN=1, PEN=0) (2)	50 105 150			
I _{DD}	Supply current ⁽¹⁾	Idle State (PON=1, AEN=PEN=0) (3)		35		μΑ
		Sleep State ⁽⁴⁾		0.54		
V _{OL}	INT, SDA output low voltage	6mA sink current			0.6	V
I _{LEAK}	Leakage current, SDA,SCL,INT		-5		5	μΑ
V _{IH}	SCL, SDA input high voltage (5)		1.26			V
V _{IL}	SCL, SDA input low voltage				0.54	V
T _{Active}	Time from power-on to ready to receive I ² C commands			1.5		ms

Note(s):

- 1. Values are shown at the VDD pin and do not include current through the IR VCSEL.
- 2. This parameter indicates the supply current during periods of ALS integration. If Wait is enabled (WEN=1), the supply current is lower during the Wait period.
- 3. Idle state occurs when PON=1 and all functions are not enabled.
- 4. Sleep state occurs when PON = 0 and I^2C bus is idle. If Sleep state has been entered as the result of operational flow, SAI = 1, PON will remain high.
- 5. Digital pins: SDA, SCL, INT are tolerant to a communication voltage up to 3.0V.

Page 6Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Figure 8: Optical Characteristics ($V_{DD} = 1.8V$, $T_A = 25^{\circ}C$ unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Unit
	Cle	ear Chann	el		
	$\lambda_{D} = 465 \text{ nm LED, } 53.8 \mu\text{W/cm}^{2}$		44.8		
Re	$\lambda_{D} = 530 \text{ nm LED, } 43.9 \mu\text{W/cm}^{2}$		86.0		count/
Irradiance responsivity	$\lambda_{D} = 620 \text{ nm LED, } 37.5 \mu\text{W/cm}^{2}$		104		(μW/cm ²)
Settings: AGAIN = 16x	Warm White LED, 45.6μW/cm ²		83.2		
ATIME = 150ms	Warm White LED, 45.6μW/cm ²	3323	3792	4361	counts
	IR Channel				
	$\lambda_D = 940 \text{ nm LED, } 21.1 \mu\text{W/cm}^2$		44.0		count/ (μW/cm ²)

Figure 9: Color/ALS Sensor Characteristics ($V_{DD} = 1.8V$, $T_A = 25^{\circ}C$ unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Unit
Integration time step size		2.68	2.78	2.90	ms
Dark ADC count value	Ee = 0μW/cm ² AGAIN: 512x ATIME = 100ms	0	1	2	counts (3)
	AGAIN = 1x	0.0145	0.016	0.0175	
	AGAIN = 4x	0.060	0.064	0.068	
Gain scaling, relative to 64x	AGAIN = 16x	0.240	0.255	0.270	×
gain setting ⁽¹⁾	AGAIN = 128x	1.8	2.0	2.2	^
	AGAIN = 256x	3.6	4.0	4.4	
	AGAIN = 512x	7.0	7.7	8.4	
ADC noise ⁽²⁾	AGAIN = 512x ATIME = 100ms		0.02		% (σ)

Note(s):

- 1. Test condition integration time = 27.8ms.
- ${\it 2. Representative \ result \ by \ characterization.}$
- 3. The typical value on 3-sigma distribution. An AGAIN setting of 16x correlates to a typically dark ADC count value less than or equal to 1.

Datasheet, PublicPage 7[v2-00] 2023-Mar-14Document Feedback



Figure 10: Proximity Optical Characteristics ($V_{DD} = 1.8V$, LEDA = 3.0V, $T_A = 25$ °C, unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Unit
Part to Part Variation ⁽¹⁾	Conditions: PGAIN = 2 (4x) PLDRIVE = 8 (19mA) PPULSE = 7 (8 pulses) PPULSE_LEN = 3 (32µs) d=23mm round target 30mm target distance	65	100	135	%
Response, Absolute	Basic proximity measurement (2) Conditions: PGAIN = 2 (4x), PLDRIVE = 8 (19mA) PPULSE = 7 (8 pulses) PPULSE_LEN = 3 (32µs) Target material: 90% reflective surface of Kodak gray card Target Size: 100mm x 100mm Target Distance: 100mm	250	312	374	counts
Noise/Signal ⁽³⁾	PGAIN = 2 (4x) PLDRIVE = 8 (19mA) PPULSE = 7 (8 pulses) PPULSE_LEN = 3 (32µs) d=23mm round target 30mm target distance			2	%

Note(s):

- 1. Production tested result is the average of 5 readings expressed relative to a calibrated response.
- 2. Representative result by characterization.
- 3. Production tested result is the average of 20 readings divided by the average response.

Page 8Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Typical Operating Characteristics

Figure 11: ALS Average Angular Response to 2700K White LED (pin1[-90°] to pin4 [90°])

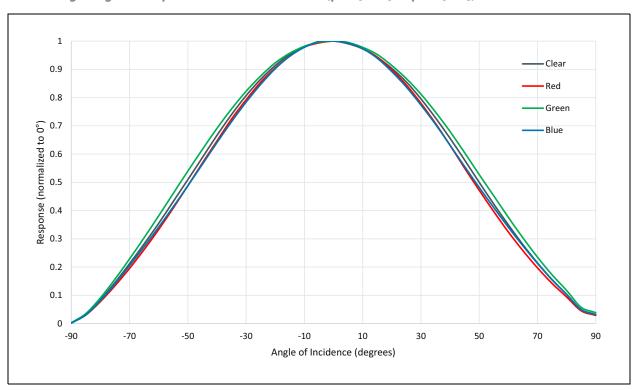
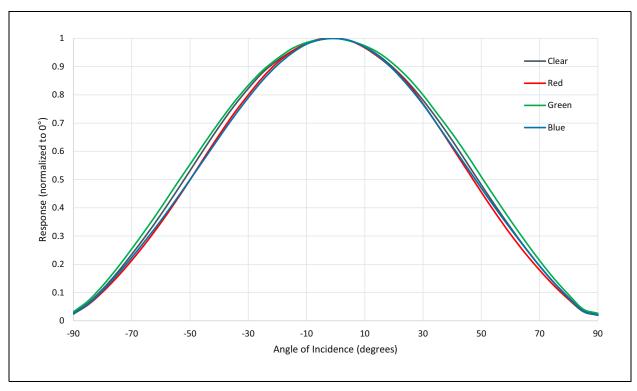


Figure 12: ALS Average Angular Response to 2700K White LED (pin4 [-90°] to pin5 [90°])



Datasheet, PublicPage 9[v2-00] 2023-Mar-14Document Feedback



Figure 13: Spectral Responsivity

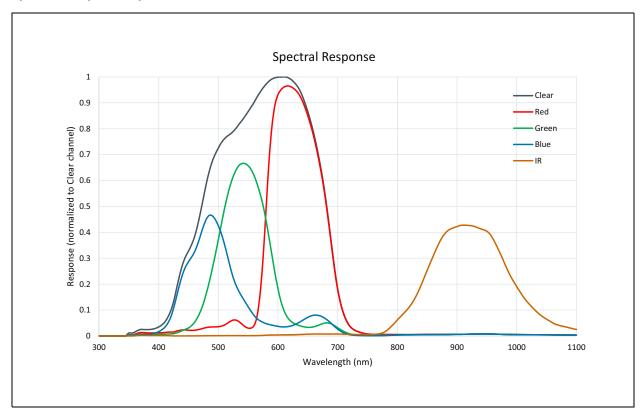
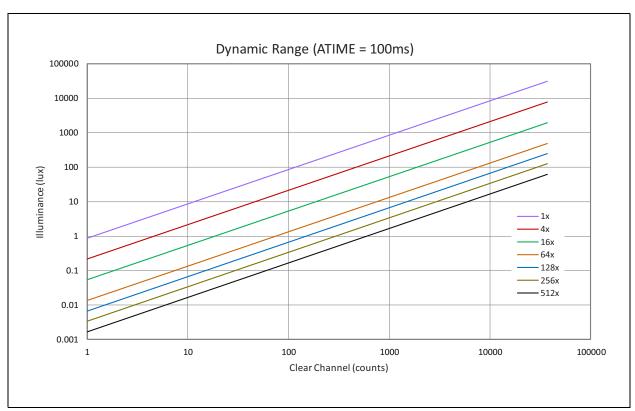


Figure 14: Illuminance (Lux) vs. Counts (Clear Channel)



Page 10
Document Feedback



Figure 15: Proximity Average Angular Response to 940nm IR LED (pin1[-90°] to pin4 [90°])

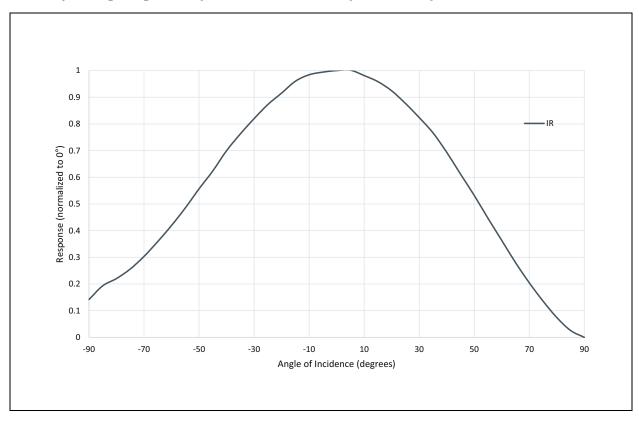
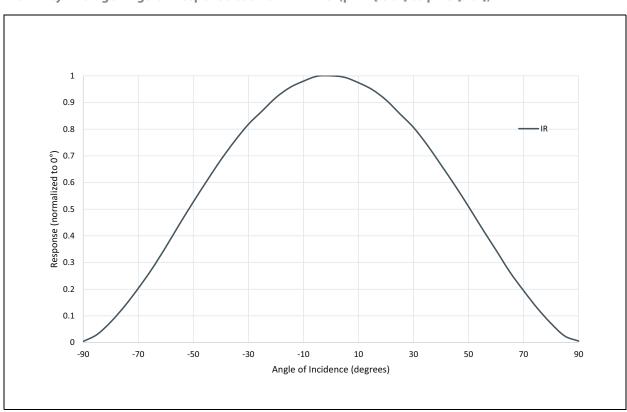


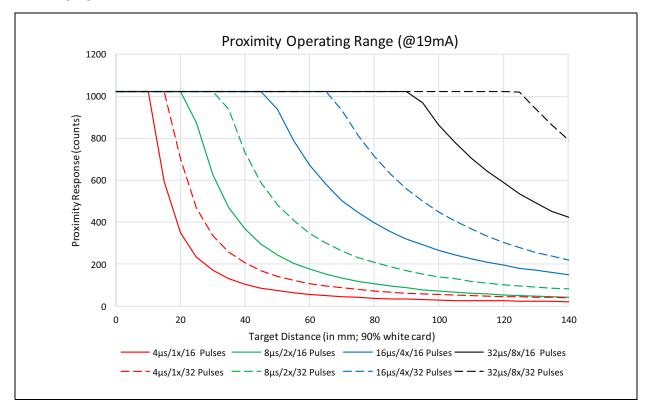
Figure 16: Proximity Average Angular Response to 940nm IR LED (pin4 [-90°] to pin5 [90°])



Datasheet, Public [v2-00] 2023-Mar-14



Figure 17: Proximity Operation



Proximity Operation: By varying Gain, VCSEL drive current, number of VCSEL pulses and VCSEL pulse duration the proximity detection range can be adjusted.

Page 12Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Detailed Description

Proximity

Proximity results are affected by three fundamental factors: the integrated IR VCSEL emission, IR reception, and environmental factors, including target distance and surface reflectivity. The IR reception signal path begins with IR detection from a photodiode and ends with the 10-bit or 14-bit proximity result in PDATA register. Signal from the photodiode is amplified, and offset adjusted to optimize performance. Offset correction or cross-talk compensation is accomplished by adjustment to the POFFSET register. The analog circuitry of the device applies the offset value as a subtraction to the signal accumulation; therefore a positive offset value has the effect of decreasing the results.

Color and Ambient Light Sense

The color and ALS reception signal path begins as photodiodes receive filtered light and ends with 16-bit results. The IR photodiode primarily used for proximity sense, is multiplexed with the green channel's ADC to measure the IR content of ambient light. The color photodiodes are filtered with a UV and IR filters. The IR photodiode is filtered to receive only IR. Signal from the RGBC photodiodes simultaneously accumulate for a period of time set by the value in ATIME before the results are available. Measurement of IR must be done in a separate integration because it shares the ADC with the green photodiode. Gain is adjustable from 1x to 512x to facilitate operation over a wide range of lighting conditions. Based on the optical glass used on top of the device, custom equations are empirically derived to calculate the amount of ambient light, color temperature, as well as, determine the light type (e.g. LED, fluorescent, incandescent, etc.) using the ALS results.

I²C Characteristics

The device uses I²C serial communication protocol for communication. The device supports 7-bit chip addressing and both standard and fast clock frequency modes with a chip address of 0x49. Read and Write transactions comply with the standard set by Philips (now NXP).

Internal to the device, an 8-bit buffer stores the register address location of the desired byte to read or write. This buffer auto-increments upon each byte transfer and is retained between transaction events (i.e. valid even after the master issues a STOP command and the I²C bus is released). During consecutive Read transactions, the future/repeated I²C Read transaction may omit the memory address byte normally following the chip address byte; the buffer retains the last register address + 1.

Datasheet, PublicPage 13[v2-00] 2023-Mar-14Document Feedback



I²C Write Transaction

A Write transaction consists of a START, CHIP-ADDRESS_{WRITE}, REGISTER-ADDRESS, DATA BYTE(S), and STOP. Following each byte (9TH clock pulse) the slave places an ACKNOWLEDGE/NOT-ACKNOWLEDGE (ACK/NACK) on the bus. If NACK is transmitted by the slave, the master may issue a STOP.

I²C Read Transaction

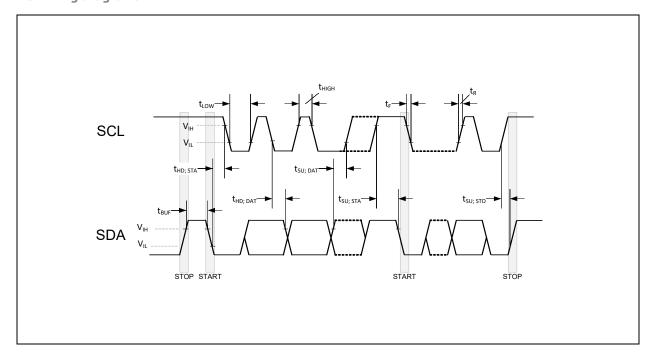
A Read transaction consists of a START, CHIP-ADDRESS $_{\rm WRITE}$, REGISTER-ADDRESS, START, CHIP-ADDRESS $_{\rm READ}$, DATA BYTE(S), and STOP. Following all but the final byte the master places an ACK on the bus (9TH clock pulse). Termination of the Read transaction is indicated by a NACK being placed on the bus by the master, followed by STOP.

Alternately, if the previous I²C transaction was a Read, the internal register address buffer is still valid, allowing the transaction to proceed without "re"-specifying the register address. In this case the transaction consists of a START, CHIP-ADDRESS_{READ}, DATA BYTE(S), and STOP. Following all but the final byte the master places an ACK on the bus (9TH clock pulse). Termination of the Read transaction is indicated by a NACK being placed on the bus by the master, followed by STOP.

The I²C bus protocol was developed by Philips (now NXP). For a complete description of the I²C protocol, please review the NXP I²C design specification at:

www.i2c-bus.org/references/

Figure 18: I²C Timing Diagrams



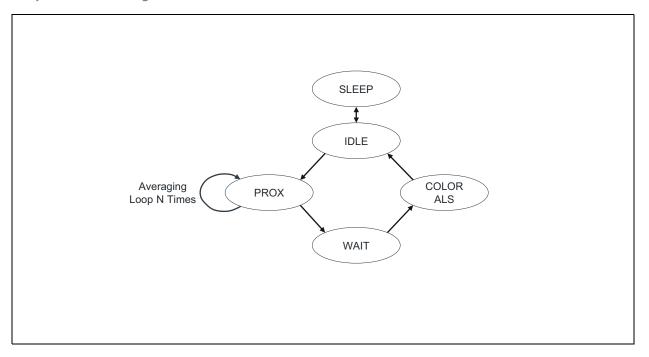
Page 14

Document Feedback

[v2-00] 2023-Mar-14



Figure 19: **Simplified State Diagram**



Datasheet, Public Page 15 [v2-00] 2023-Mar-14 Document Feedback



Register Description

Figure 20: Register Overview

Address	Register Name	R/W	Register Function	Reset Value
0x80	ENABLE	R/W	Enables states	0x00
0x81	ATIME	R/W	ADC integration time	0x00
0x82	PRATE	R/W	Proximity time	0x1F
0x83	WTIME	R/W	Wait time	0x00
0x84	AILTL	R/W	ALS interrupt low threshold low byte	0x00
0x85	AILTH	R/W	ALS interrupt low threshold high byte	0x00
0x86	AIHTL	R/W	ALS interrupt high threshold low byte	0x00
0x87	AIHTH	R/W	ALS interrupt high threshold high byte	0x00
0x88	PILTL	R/W	Proximity interrupt low threshold low byte	0x00
0x89	PILTH	R/W	Proximity interrupt low threshold high byte	0x00
0x8A	PIHTL	R/W	Proximity interrupt high threshold low byte	0x00
0x8B	PIHTH	R/W	Proximity interrupt high threshold high byte	0x00
0x8C	PERS	R/W	ALS and proximity interrupt persistence filters	0x00
0x8D	CFG0	R/W	Configuration zero	0x40
0x8E	PCFG0	R/W	Proximity configuration zero	0x4F
0x8F	PCFG1	R/W	Proximity configuration one	0x80
0x90	CFG1	R/W	Configuration one	0x09
0x91	REVID	R	Revision ID	0x01
0x92	ID	R	Device ID	0x10
0x93	STATUS	R, SC	Device status	0x00
0x94	CDATAL	R	Clear ADC low data	0x00
0x95	CDATAH	R	Clear ADC high data	0x00
0x96	RDATAL	R	Red ADC low data	0x00
0x97	RDATAH	R	Red ADC high data	0x00
0x98	GDATAL	R	Green (or IR) ADC low data	0x00
0x99	GDATAH	R	Green (or IR) ADC high data	0x00
0x9A	BDATAL	R	Blue ADC low data	0x00

Page 16
Document Feedback



Address	Register Name	R/W	Register Function	Reset Value
0x9B	BDATAH	R	Blue ADC high data	0x00
0x9C	PDATAL	R	Proximity ADC low data	0x00
0x9D	PDATAH	R	Proximity ADC high data	0x00
0x9E	REVID2	R	Revision ID two	0x07
0x9F	CFG2	R/W	Configuration two	0x00
0xA0	SOFTRST	R/W	Soft reset	0x00
0xAB	CFG3	R/W	Configuration three	0x04
0xAC	CFG4	R/W	Configuration four (must be set to 0x3D)	0x3F
0xAE	CFG6	R/W	Configuration six	0x3F
0xC0	POFFSETL	R/W	Proximity offset low data	0x00
0xC1	POFFSETH	R/W	Proximity offset high data	0x00
0xD7	CALIB	R/W	Proximity offset calibration	0x00
0xD9	CALIBCFG	R/W	Proximity offset calibration control	0x50
0xDC	CALIBSTAT	R	Proximity offset calibration status	0x00
0xDD	INTENAB	R/W	Interrupt enables	0x00
0xE6	FAC_L	R	Factory data low (lot code data)	0x00 to 0xFF
0xE7	FAC_H	R	Factory data high (lot code data)	0x00 to 0xFF
0xF2	TEST3	R/W	Test three (must be set to 0xC4)	0x44



Enable Register (Address 0x80)

Figure 21: Enable Register

A	ddr:0x80			Enable		
Bit	Bit Name	Default	Access	Bit Description		
7:4	Reserved	0	RW	Reserved. Must be set to default value.		
3	WEN	0	RW	This bit activates the wait feature. Active high.		
2	PEN	0	RW	This bit activates the proximity detection. Active high.		
1	AEN	0	RW	This bit actives the ALS function. Active high.		
0	PON	0	RW	This field activates the internal oscillator and ADC channels. Active high.		

Before activating AEN or PEN, preset each applicable operating mode registers and bits.

Page 18Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



ATIME Register (Address 0x81)

Figure 22: **ATIME Register**

Addr:0x81		ATIME						
Bit	Bit Name	Default	Access		Bit De	scription		
	ATIME	0x00	RW	ALS/Color value that specifies the integration time in 2.78ms intervals. 0x00 indicates 2.78ms. The maximum ALS value depends on the integration time. For every 2.78ms, the maximum value increases by 1024. This means that to be able to reach ALS full scale, the integration time has to be at least 64*2.78ms.				
				Value	Integration Cycles	Integration Time	Maximum ALS Value	
7:0				0x00	1	2.78ms	1023	
				0x01	2	5.56ms	2047	
				0x11	18	50.0ms	18431	
				0x23	36	100ms	36863	
				0x3F	64	178ms	65535	
				0xFF	256	712ms	65535	

The ATIME register controls the integration time of the ALS ADCs. The timer is implemented with a down counter with 0x00 as the terminal count. The timer is clocked at a 2.78ms nominal rate. Loading 0x00 will generate a 2.78ms integration time, loading 0x01 will generate a 5.56ms integration time, and so forth.

PRATE Register (Address 0x82)

Figure 23: **PRATE** Register

Addr:0x82		PRATE			
Bit	Bit Name	Default	Access	Bit Description	
7:0	PRATE	0x1F	RW	This register defines the duration of 1 Prox Sample, which is (PRATE + 1)*88µs.	

Datasheet, Public Page 19 **Document Feedback**



WTIME Register (Address 0x83)

Figure 24: WTIME Register

Addr:0x83		WTIME					
Bit	Bit Name	Default Access Bit Description			ription		
	7:0 WTIME 0x00		Value that specifies the wait time between ALS and proximity cycles in 2.78ms increments				
			Value	Increments	Wait Time		
				0x00	1	2.78ms (33.4ms)	
7:0		0x00	RW	0x01	2	5.56ms (66.7ms)	
				0x11	18	50.0ms (600ms)	
				0x23	36	100ms (1.20s)	
			0x3F	64	178ms (2.14s)		
				0xFF	256	712ms (8.54s)	

The wait timer is implemented using a down counter. Wait time = Increment x 2.78ms. If WLONG is enabled then, Wait time = Increment x 2.78ms x 12.

Page 20Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



AILTL Register (Address 0x84)

Figure 25: AILTL Register

Addr:0x84		AILTL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AILTL	0x00	RW	This register sets the low byte of the LOW ALS threshold.	

AILTH Register (Address 0x85)

Figure 26: AILTH Register

Addr: 0x85		AILTH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AILTH	0x00	RW	This register sets the high byte of the LOW ALS threshold.	

The Clear (C) channel is compared against low-going 16-bit threshold value set by AILTL and AILTH.

The contents of the AILTH and AILTL registers are combined and treated as a sixteen bit threshold value. If the value generated by the C channel is below the AILTL/H threshold and the APERS value is reached, the AINT bit is asserted. If AIEN is set, then the INT pin will also assert.

When setting the 16-bit ALS threshold AILTL must be written first, immediately followed by AILTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 16-bit value.

Datasheet, PublicPage 21[v2-00] 2023-Mar-14Document Feedback



AIHTL Register (Address 0x86)

Figure 27: **AIHTL Register**

Addr: 0x86		AIHTL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AIHTL	0x00	RW	This register sets the low byte of the HIGH ALS threshold.	

AIHTH Register (Address 0x87)

Figure 28: **AIHTH Register**

Addr: 0x87		AIHTH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AIHTH	0x00	RW	This register sets the high byte of the HIGH ALS threshold.	

The Clear (C) channel is compared against high-going 16-bit threshold value set by AIHTL and AIHTH.

The contents of the AIHTH and AIHTL registers are combined and treated as a sixteen bit threshold value. If the value generated by the C channel is above the AIHTL/H threshold and the APERS value is reached, the AINT bit is asserted. If AIEN is set, then the INT pin will also assert.

When setting the 16-bit ALS threshold AIHTL must be written first, immediately followed by AIHTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 16-bit value.

Page 22 Datasheet, Public [v2-00] 2023-Mar-14



PILTL Register (Address 0x88)

Figure 29: **PILTL Register**

Addr: 0x88		PILTL			
Bit	Bit Name	Default Access		Bit Description	
7:0	PILTL	0x00	RW	This register contains the low byte of the 14-bit proximity LOW threshold when APC is enabled. If APC is disabled, this register contains the LOW threshold which is an 8-bit value which is compared against the upper 8-bits of the 10-bit proximity value.	

PILTH Register (Address 0x89)

Figure 30: **PILTH Register**

Addr: 0x89		PILTH			
Bit	Bit Name	Default	Access	Bit Description	
7:6	Reserved	00	RW	Reserved. Must be set to default value.	
5:0	PILTH	0x00	RW	This register contains the upper 6 bits of the 14-bit proximity LOW threshold when APC is enabled. If APC is disabled, this register is ignored.	

The contents of the PILTH and PILTL registers are combined and treated as a fourteen (14) bit threshold low value. If the value generated by the proximity ADC (PDATA) is below the PILTL/H threshold and the PPERS value is reached, the PINT bit is asserted. If PIEN is set, then the INT pin will also assert. When setting the 14-bit proximity threshold, PILTL must be written first, immediately follow by PILTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 14-bit value.

If Automatic Pulse Control (APC) is disabled by setting bit 6 in CFG6 to 1, then the proximity data converts to a 10-bit value. PILTL contains a 8-bit threshold which is compared against the upper 8-bits of the 10-bit value. PILTH is ignored.

Datasheet, Public Page 23 Document Feedback



PIHTL Register (Address 0x8A)

Figure 31: **PIHTL Register**

Addr: 0x8A		PIHTL				
Bit	Bit Name	Default Access		Bit Description		
7:0	PIHTL	0x00	RW	This register contains the low byte of the 14-bit proximity HIGH threshold when APC is enabled. If APC is disabled, this register contains the HIGH threshold which is an 8-bit value which is compared against the upper 8-bits of the 10-bit proximity value.		

PIHTH Register (Address 0x8B)

Figure 32: **PIHTH Register**

Addr: 0x8B		PIHTH			
Bit	Bit Name	Default	Access	Bit Description	
7:6	Reserved	00	RW	Reserved. Must be set to default value.	
5:0	PIHTH	0x00	RW	This register contains the upper 6 bits of the 14-bit proximity HIGH threshold when APC is enabled. If APC is disabled, this register is ignored.	

The contents of the PIHTH and PIHTL registers are combined and treated as a fourteen (14) bit threshold high value. If the value generated by the proximity ADC (PDATA) is above the PIHTL/H threshold and the PPERS value is reached, the PINT bit is asserted. If PIEN is set, then the INT pin will also assert. When setting the 14-bit proximity threshold, PIHTL must be written first, immediately follow by PIHTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 14-bit value.

If Automatic Pulse Control (APC) is disabled by setting bit 6 in CFG6 to 1, then the proximity data converts to a 10-bit value. PIHTL contains a 8-bit threshold which is compared against the upper 8-bits of the 10-bit value. PIHTH is ignored.

Page 24 Datasheet, Public [v2-00] 2023-Mar-14



PERS Register (Address 0x8C)

Figure 33: PERS Register

Add	Addr: 0x8C		PERS					
Bit	Bit Name	Default	Access		Bit Description			
				This register	sets the proximity persistence filter.			
				Value	Interrupt			
				0 (0000)	Every proximity cycle			
7:4	PPERS	0	RW	1 (0001)	Any value outside proximity thresholds			
7.4	I I LIIS	(0000)	11.00	2 (0010)	2 consecutive proximity values out of range			
				3 (0011)	3 consecutive proximity values out of range			
				15 (1111)	15 consecutive proximity values out of range			
				This register	r sets the ALS persistence filter.			
				0 (0000)	Every ALS cycle			
				1 (0001)	Any value outside ALS thresholds			
				2 (0010)	2 consecutive ALS values out of range			
				3 (0011)	3 consecutive ALS values out of range			
				4 (0100)	5 consecutive ALS values out of range			
3:0	APERS	0 (0000)	RW	5 (0101)	10 consecutive ALS values out of range			
				6 (0110)	15 consecutive ALS values out of range			
				7 (0111)	20 consecutive ALS values out of range			
				13 (1101)	50 consecutive ALS values out of range			
				14 (1110)	55 consecutive ALS values out of range			
				15 (1111)	60 consecutive ALS values out of range			

The frequency of consecutive proximity channel results outside of threshold limits are counted; this count value is compared against the PPERS value. If the counter is equal to the PPERS value an interrupt is asserted. Any time a proximity channel result is inside the threshold values the counter is cleared.



The frequency of consecutive Clear (C) channel results outside of threshold limits are counted; this count value is compared against the APERS value. If the counter is equal to the APERS setting an interrupt is asserted. Any time a Clear (C) channel result is inside the threshold values the counter is cleared.

CFG0 Register (Address 0x8D)

Figure 34: CFG0 Register

Addr: 0x8D		CFG0			
Bit	Bit Name	Default	Access	Bit Description	
7:3	Reserved	01000	RW	Reserved. Must be set to default value.	
2	WLONG	0	RW	When WLONG (Wait Long) is asserted the wait period as set by WTIME is increased by a factor of 12.	
1	Reserved	0	RW	Reserved. Must be set to default value.	
0	PPULSE_ LEN_16x	0	RW	When PPULSE_LEN_16X is asserted, the proximity pulse length is extended by a factor of 16. See the PPULSE_LEN bit description in the PCFG0 register.	

PCFG0 Register (Address 0x8E)

Figure 35: PCFG0 Register

Addr: 0x8E		PCFG0				
Bit	Bit Name	Default	Access	Bit Description		
	7:6 PPULSE_LEN 1 (01)		RW	Proximity pulse length. The pulse length can be extended by a factor of 16x with the assertion of the PPULSE_LEN_16x bit in CFG0.		
		1 (01)		Value	Pulse Length	
7:6				0 (00)	4μs / 64μs	
				1 (01)	8μs / 128μs	
				2 (10)	16μs / 256μs	
				3 (11)	32μs / 512μs	

Page 26Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Addr: 0x8E		PCFG0				
Bit	Bit Name	Default	Access		Bit Description	
	5:0 PPLUSE 15 (001111)			Maximum nur	mber of pulses in a single proximity cycle.	
			I RW I	Value	Maximum Number of Pulses	
				0 (000000)	1	
5:0		_		1 (000001)	2	
				2 (000010)	3	
				63 (111111)	64	

The PPULSE_LEN field sets the length (width) of all IR VCSEL pulses within the proximity cycle. Longer pulses result in increased proximity range and typically result in less electrical noise generated in the analog front end. If the PPULSE_LEN_ 16x bit in CFG0 is asserted, then the pulse length is extended by a factor of 16 times.

The PPULSE field sets the maximum number of IR VCSEL pulses that may occur in a proximity cycle. The proximity engine will automatically continue to add IR VCSEL pulses, up to the value set in PPULSE or if a near-saturation condition occurs. The dynamic range of the sensor is automatically adjusted to detect distant targets as well as prevent saturation from close targets. This operation also reduces power consumption because proximity integration period is automatically shortened when a target is either too close or far from the sensor.

If Automatic Pulse Control (APC) is disabled by setting bit 6 in CFG6 to 1, then PPULSE always determines the number of proximity to be transmitted.

Datasheet, PublicPage 27[v2-00] 2023-Mar-14Document Feedback



PCFG1 Register (Address 0x8F)

Figure 36: PCFG1 Register

Addr: 0x8F		PCFG1				
Bit	Bit Name	Default	Access	Bit Description		
				This field sets the gain of th	ne proximity IR sensor.	
				Value	Gain	
7:6	PGAIN	2	RW	0 (00)	1x	
7.0	7 3/111	(10)		1 (01)	2x	
				2 (10)	4x	
				3 (11)	8x	
5:4	Reserved	00	RW	Reserved. Must be set to default value.		
				This field sets the drive stre current. Values are approxi through VCSEL is factory tri intensity. Note: Bit 5 in CFG1 must be currents will be 2x the nom	mate; actual current immed to normalize IR e set to a 1 or the VCSEL	
				Value	VCSEL Current	
				0 (0000)	2mA	
				1 (0001)	4mA	
3:0	PLDRIVE	0 (0000)	RW	2 (0010)	6mA	
		, ,		3 (0011)	8mA	
				4 (0100)	10mA	
				5 (0101)	12mA	
				6 (0110)	14mA	
				7 (0111)	17mA	
				8 (1000)	19mA	
				All other values	Reserved	

Page 28Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



CFG1 Register (Address 0x90)

Figure 37: **CFG1** Register

Ad	Addr: 0x90		CFG1				
Bit	Bit Name	Default	Access	Bit Des	cription		
7	Reserved	0	RW	Reserved. Must be set to def	ault value.		
6	IR_MUX	0	RW	RW If set high, the IR (proximity) photodiode is switched in the Green channel's data converter. GDATAL/H regist will report IR content. Green photodiode is not connected in this mode (1).			
5	Reserved	0	RW	Reserved. Must be set to 1. If this bit is 0, the VCSEL current will be 2x the nominal value.			
				This field sets the gain of the ALS/Color sensor.			
				Value	ALS Gain		
				1 (00001)	1x		
				3 (00011)	4x		
4:0	AGAIN	9	RW	5 (00101)	16x		
4.0	AGAIN	(01001)	NVV	7 (00111)	64x		
				8 (01000)	128x		
				9 (01001)	256x		
				10 (01010)	512x		
				All other values	Reserved		

Note(s):

REVID Register (Address 0x91)

Figure 38: **REVID Register**

Addr: 0x91		REVID			
Bit	Bit Name	Default	Access	Bit Description	
7:3	Reserved	00000	RO	Reserved.	
2:0	REV_ID	001	RO	Device revision number.	

Datasheet, Public Page 29 [v2-00] 2023-Mar-14 **Document Feedback**

^{1.} The IR multiplexer is not synchronized to the ALS/Color measurement sequencer. It is recommended that after the IR_MUX bit is $changed, to either discard the first ALS/color \, measurement \, or \, wait \, at \, least \, two \, ALS/color \, integration \, times \, before \, reading \, the \, results.$



ID Register (Address 0x92)

Figure 39: ID Register

Addr: 0x92		ID			
Bit	Bit Name	Default	Access	Bit Description	
7:2	ID	000100	RO	Device type identification.	
1:0	Reserved	00	RO	Reserved	

Status Register (Address 0x93)

Figure 40: Status Register

Addr: 0x93		Status Register			
Bit	Bit Name	Default	Access	Bit Description	
7	ASAT	0	R, SC	Analog saturation flag signals that the ALS/Color results may be unreliable due to saturation of the AFE.	
6	PSAT	0	R, SC	Proximity saturation flag indicates that an ambient- or reflective-saturation event occurred during a previous proximity cycle.	
5	PINT	0	R, SC	Proximity interrupt flag indicates that proximity results have exceeded thresholds and persistence settings.	
4	AINT	0	R, SC	ALS interrupt flag indicates that ALS/Color results (clear channel) have exceeded thresholds and persistence settings.	
3	CINT	0	R, SC	Calibration interrupt flag indicates that calibration has completed.	
2	ZINT	0	R, SC	Zero detection interrupt flag indicates that a zero value in PDATA has caused the proximity offset to be decremented (if AUTO_OFFSET_ADJ = 1).	
1	PSAT_REFLECTIVE	0	R, SC	The reflective proximity saturation interrupt flag signals that the AFE has saturated during the IR VCSEL active portion of proximity integration.	
0	PSAT_AMBIENT	0	R, SC	The ambient proximity saturation interrupt flag signals that the AFE has saturated during the IR VCSEL inactive portion of proximity integration.	

All flags in this register can be cleared by setting the bit high. Alternatively, if the INT_READ_CLEAR in the CFG3 register bit is set, then simply reading this register automatically clears all eight flags.

Page 30Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



CDATAL Register (Address 0x94)

Figure 41: CDATAL Register

Addr: 0x94		CDATAL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	CDATAL	0x00	RO	This register contains the low byte of the 16-bit clear channel data.	

CDATAH Register (Address 0x95)

Figure 42: CDATAH Register

Addr: 0x95		CDATAH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	CDATAH	0x00	RO	This register contains the high byte of the 16-bit clear channel data.	

RDATAL Register (Address 0x96)

Figure 43: RDATAL Register

Addr: 0x96		RDATAL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	RDATAL	0x00	RO	This register contains the low byte of the 16-bit red channel data.	

RDATAH Register (Address 0x97)

Figure 44: RDATAH Register

Addr: 0x97		RDATAH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	RDATAH	0x00	RO	This register contains the high byte of the 16-bit red channel data.	

Datasheet, PublicPage 31[v2-00] 2023-Mar-14Document Feedback



GDATAL Register (Address 0x98)

Figure 45: GDATAL Register

Addr: 0x98		GDATAL		
Bit	Bit Name	Default	Access	Bit Description
7:0	GDATAL	0x00	RO	This register contains the low byte of the 16-bit green channel data (or IR data if IR_MUX bit in CFG1 = 1).

GDATAH Register (Address 0x99)

Figure 46: GDATAH Register

Addr: 0x99				GDATAH
Bit	Bit Name	Default	Access	Bit Description
7:0	GDATAH	0x00	RO	This register contains the high byte of the 16-bit green channel data (or IR data if IR_MUX bit in CFG1 = 1).

BDATAL Register (Address 0x9A)

Figure 47: BDATAL Register

Addr: 0x9A				BDATAL
Bit	Bit Name	Default	Access	Bit Description
7:0	BDATAL	0x00	RO	This register contains the low byte of the 16-bit blue channel data.

BDATAH Register (Address 0x9B)

Figure 48: BDATAH Register

Addr: 0x9B		BDATAH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	BDATAH	0x00	RO	This register contains the high byte of the 16-bit blue channel data.	

Page 32Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



PDATAL Register (Address 0x9C)

Figure 49: **PDATAL Register**

Addr: 0x9C		PDATAL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	PDATAL	0x00	RO	This register contains the low byte of the 14-bit proximity ADC data when APC is enabled. If APC is disabled, this register contains the upper 8 most significant bits of the 10-bit proximity value.	

PDATAH Register (Address 0x9D)

Figure 50: **PDATAH Register**

Addr: 0x9D		PDATAH				
Bit	Bit Name	Default	Access	Bit Description		
7:0	PDATAH	0x00	RO	This register contains the high byte of the 14-bit proximity ADC data when APC is enabled. If APC is disabled, bits 1:0 contain the lower 2 bits of the 10-bit proximity value.		

Proximity data is stored as a 14-bit value (two bytes). Reading the low byte first latches the high byte. Proximity detection uses an Automatic Pulse Control (APC) mechanism that adjusts the number of pulses per measurement based on the magnitude of the reflected IR signal. As the magnitude of the signal increases, the number of pulses decreases. Proximity detection uses a 10-bit ADC that is extended to a 14-bit dynamic range for PDATA using the following formula:

PDATA = $ADC_{value} x$ (16 / actual number of pulses transmitted)

PDATA is therefore proportional to the reflected energy independent of the number of pulses transmitted.

If Automatic Pulse Control (APC) is disabled by setting bit 6 in CFG6 to 1, then the proximity data converts to a 10-bit value. PDATAL contains the 8 most significant bits of the 10-bit value and PDATAH bit locations 1:0 contain the lower 2-bits. When APC is disabled, only the upper 8-bits are compared against the threshold values contained in PILTL and PIHTL.

Datasheet, Public Page 33 Document Feedback



REVID2 Register (Address 0x9E)

Figure 51: **REVID2 Register**

Addr: 0x9E		REVID2				
Bit	Bit Name	Default	Access	Bit Description		
7:4	Reserved	0000	RO	Reserved.		
3:0	REV_ID	0111	RO	Device revision number.		

CFG2 Register (Address 0x9F)

Figure 52: **CFG2** Register

Addr: 0x9F				CFG2	
Bit	Bit Name	Default	Default Access Bit Description		
7:0	Reserved	0	RW	Reserved. Must be set to default value.	

SOFTRST Register (Address 0xA0)

Figure 53: **SOFTRST Register**

Addr: 0xA0		SOFTRST				
Bit	Bit Name	Default	Access	Bit Description		
7:1	Reserved	0	RW	Reserved. Must be set to default value.		
0	SOFTRST	0	RW	Writing a 1 to this bit will cause all registers to be reset to their default state. This will immediately terminate all device operation and put the device into the sleep state.		

Page 34 Datasheet, Public **Document Feedback** [v2-00] 2023-Mar-14



CFG3 Register (Address 0xAB)

Figure 54: **CFG3 Register**

А	Addr: 0xAB		CFG3						
Bit	Bit Name	Default	Access		Bit Description				
7	INT_READ_CLEAR	0	RW	If set, then all flag bits in the STATUS register wi reset whenever the STATUS register is read ove					
6:5	Reserved	0	RW	Reserved. Must be set to default value.			·.		
					ter Interrupt k I low power m		place the n interrupt pin		
				PON	SAI	INT	Oscillator		
4	SAI	0	RW	0	Х	Х	OFF		
				1	0	Х	ON		
				1	1	1	ON		
				1	1	0	OFF		
3:0	Reserved	0100	RW	Reserved. M	ust be set to d	lefault value	· !.		

The SAI bit sets the device operational mode following the completion of an ALS or proximity cycle. If AINT and AIEN are both set or if PINT and PIEN are both set, causing an interrupt on the INT pin, and the SAI bit is set, then the oscillator will deactivate. The device will appear as if PON = 0, however, PON will read as 1. The device can only be reactivated (oscillator enabled) by clearing the interrupts in the STATUS register.

CFG4 Register (Address 0xAC)

Figure 55: **CFG4** Register

Ad	Addr: 0xAC			CFG4	
Bit	Bit Name	Default Access Bit Description			
7:0	Reserved	0x3F	RW	Reserved. Must be set to 0x3D.	

Datasheet, Public Page 35 [v2-00] 2023-Mar-14 **Document Feedback**



CFG6 Register (Address 0xAE)

Figure 56: CFG6 Register

Add	r: 0xAE			CFG6
Bit	Bit Name	Default	Access	Bit Description
7	Reserved	0	RW	Reserved. Must be set to default value.
6	APC Disable	0	RW	Proximity automatic pulse control (APC) disable. 0 = APC enabled 1 = APC disabled
5:0	Reserved	111111	RW	Reserved. Must be set to default value.

POFFSETL Register (Address 0xC0)

Figure 57: POFFSETL Register

Addr: 0xC0		POFFSETL			
Bit	Bit Name	Default Access Bit Description			
7:0	POFFSETL	0x00	RW	This register contains the magnitude portion of proximity offset adjust value.	

POFFSETH Register (Address 0xC1)

Figure 58: POFFSETH Register

Addr: 0xC1			POFFSETH		
Bit	Bit Name	Default Access		Bit Description	
7:1	Reserved	0	RW	Reserved. Must be set to default value.	
0	POFFSETH	0	RW	This register contains the sign portion of proximity offset adjust value.	

Typically, optical and/or electrical crosstalk negatively influence proximity operation and results. The POFFSETL/POFFSETH registers provide a mechanism to remove system crosstalk from the proximity data. POFFSETL and POFFSETH contains the magnitude and sign of a value which adjusts PDATA is generated in the AFE. An offset value in the range of $\pm\ 255$ is possible.

Page 36Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



CALIB Register (Address 0xD7)

Figure 59: CALIB Register

Ac	ldr: 0xD7	CALIB			
Bit	Bit Name	Default Access		Bit Description	
7:6	Reserved	0	RW	Reserved. Must be set to default value.	
5	ELECTRICAL_ CALIBRATION	0	RW	Selects proximity calibration type. 0 = Electrical and optical crosstalk. 1 = Electrical crosstalk only.	
4:1	Reserved	0	RW	Reserved. Must be set to default value.	
0	START_OFFSET_ CAL	0	RW	Set to 1 to start a calibration sequence.	

Proximity response in systems with electrical and optical crosstalk may be improved by using the calibration feature. Optical crosstalk is caused when the photodiode receives a portion of the VCSEL IR which was unintentionally reflected by a surface other than the target. Electrical offset is caused by electrical disturbance in the sensor AFE, and also influences the proximity result. The calibration routine adjusts the value in POFFSETL/H until the proximity result is as close to the binary search target as possible. Optical and electrical calibration function identically, except that during an electrical calibration the proximity photodiode is disconnected from the AFE.

An electrical calibration can be initiated anytime by setting the ELECTRICAL_CALIBRATION and START_OFFSET_CAL bits. To perform an optical (and electrical) calibration do not set the ELECTRICAL_CALIBRATION bit when setting the START_OFFSET_CALIB. The CINT flag will assert after calibration has finished. Upon completion proximity offset registers are automatically loaded with calibration result.

Datasheet, PublicPage 37[v2-00] 2023-Mar-14Document Feedback



CALIBCFG Register (Address 0xD9)

Figure 60: CALIBCFG Register

Addr: 0xD9		CALIBCFG				
Bit	Bit Name	Default	Access	Bit Description		
				Proximity offset calibration result target.		
				Value	PDATA Target	
				0 (000)	3	
				1 (001)	7	
7:5	BINSRCH_	2	RW	2 (010)	15	
7.5	TARGET	(010)	NVV	3 (011)	31	
				4 (100)	63	
				5 (101)	127	
				6 (110)	255	
				7 (111)	511	
4	Reserved	1	RW	Reserved. Must be set to default value.		
3	AUTO_ OFFSET_ADJ	0	RW	If set, this bit causes the value in POFFSETL register to be decremented if PDATA ever becomes zero.		
					er of ADC samples collected and become the proximity result.	
				Value	Sample Size	
				0 (000)	Disable	
				1 (001)	2	
2:0	PROX_ AVG	0 (000)	RW	2 (010)	4	
	AVG	(000)		3 (011)	8	
				4 (100)	16	
				5 (101)	32	
				6 (110)	64	
				7 (111)	128	

Page 38Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



The binary search target field is used by the calibration feature to set the baseline value for PDATA when no target is present. For example, calibration of a device in open air, with no target, and BINSEARCH_TARGET setting of 2 causes the PDATA value will be approximately 15 counts. This feature is useful because it forces PDATA result to always be above zero.

The PROX_AVG field sets the number of ADC samples that are averaged to calculate the PDATA result.

CALIBSTAT Register (Address 0xDC)

Figure 61: **CALIBSTAT Register**

Addr: 0xDC		CALIBSTAT			
Bit	Bit Name	Default	Access	Bit Description	
7:3	Reserved	0	RW	Reserved. Must be set to default value.	
2	OFFSET_ ADJUSTED	0	RW	Bit is set when the proximity offset has been automatically decremented if AUTO_OFFSET_ ADJ = 1 (see CALIBCFG register). This bit can be cleared by writing 1 to it or setting AUTO_ OFFSET_ADJ to 0.	
1	Reserved	0	RW	Reserved. Must be set to default value.	
0	CALIB_FINISHED	0	RW	This flag indicates that calibration has finished. This bit is a copy of the CINT bit in the STATUS register. It will be cleared when the CINT bit is cleared.	

INTENAB Register (Address 0xDD)

Figure 62: **INTENAB** Register

Add	r: 0xDD	INTENAB			
Bit	Bit Name	Default	Access	Bit Description	
7	ASIEN	0	RW	ALS Saturation Interrupt Enable	
6	PSIEN	0	RW	Proximity Saturation Interrupt Enable	
5	PIEN	0	RW	Proximity Interrupt Enable	
4	AIEN	0	RW	ALS/Color Interrupt Enable	
3	CIEN	0	RW	Calibration Interrupt Enable	
2	ZIEN	0	RW	Zero Detect Interrupt Enable	
1:0	Reserved	0	RW	Reserved. Must be set to default value.	

Datasheet, Public Page 39 [v2-00] 2023-Mar-14 **Document Feedback**



FAC_L Register (Address 0xE6)

Figure 63: FAC_L Register

Addr: 0xE6			FAC_L	
Bit	Bit Name	Default	Access	Bit Description
7:0	Reserved	0x00 – 0xFF	R	Reserved for lot code data

FAC_H Register (Address 0xE7)

Figure 64: FAC_H Register

Addr: 0xE7				FAC_H
Bit	Bit Name	Default	Access	Bit Description
7:0	Reserved	0x00 – 0xFF	R	Reserved for lot code data

TEST3 Register (Address 0xF2)

Figure 65: TEST3 Register

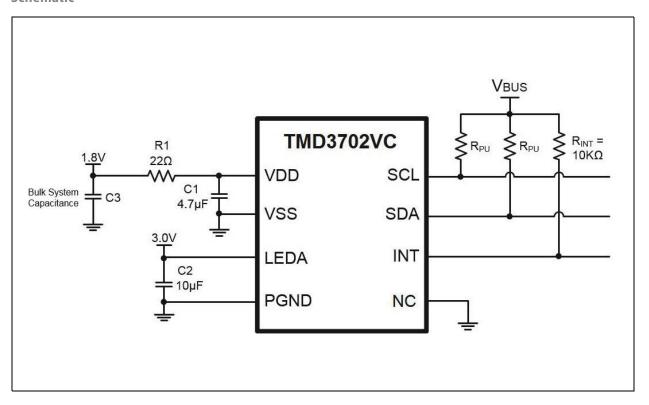
A	Addr: 0xF2		TEST3			
Bit	Bit Name	Default	Access	Bit Description		
7:0	Reserved	0x44	RW	Reserved. Must be set to 0xC4.		

Page 40Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Application Information

Figure 66: **Schematic**



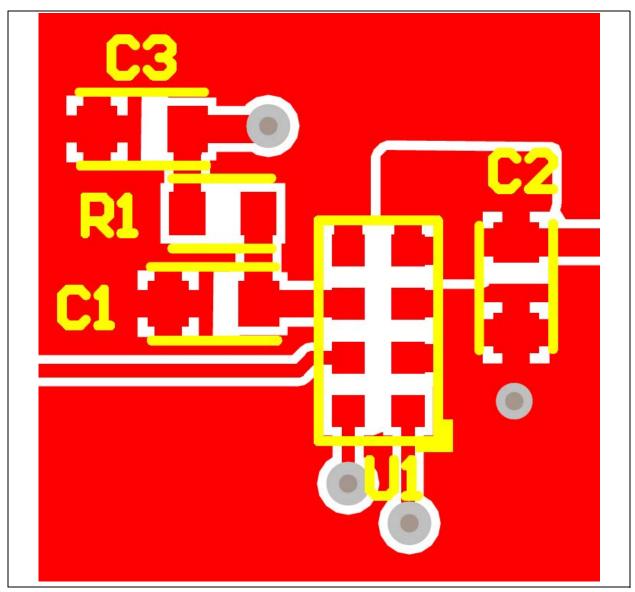
Note(s):

- $1. The \ bulk\ capacitor\ (C3)\ can\ affect\ the\ stability\ of\ a\ regulated\ supply\ output\ and\ should\ be\ chosen\ with\ the\ regulator\ characteristics$
- 2. Place the $4.7\mu F\,VDD$ (C1) and $10\mu F\,LEDA$ (C2) capacitors within 5mm of the module.
- 3. The value of the I^2C pull up resistors RPU should be based on the 1.8V bus voltage, system bus speed and trace capacitance.
- 4. VSS and PGND should be connected to the same solid ground plane as close to the device as possible.
- 5. To improve device ESD protection, it is recommended to connect NC to ground.

Datasheet, Public Page 41 **Document Feedback** [v2-00] 2023-Mar-14



Figure 67: TMD3702VC Recommended Circuit Layout



Note(s):

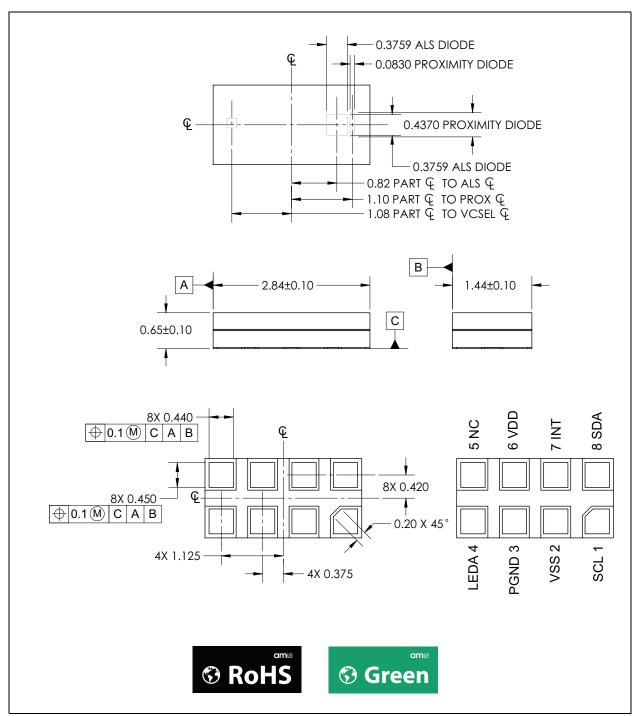
1. The dominant factor governing device performance is the component placement, not necessarily component value. The placement of the decoupling capacitor, C2, is the most critical. Place the component on the same side of PCB as device as shown in the figure above. Make connection as close as possible to minimize series inductance and resistance. This is critical.

Page 42Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Package Drawings & Markings

Figure 68: Package Drawing



Note(s):

- 1. All linear dimensions are in millimeters.
- 2. Contact finish is Au.
- 3. This package contains no lead (Pb).
- 4. This drawing is subject to change without notice.

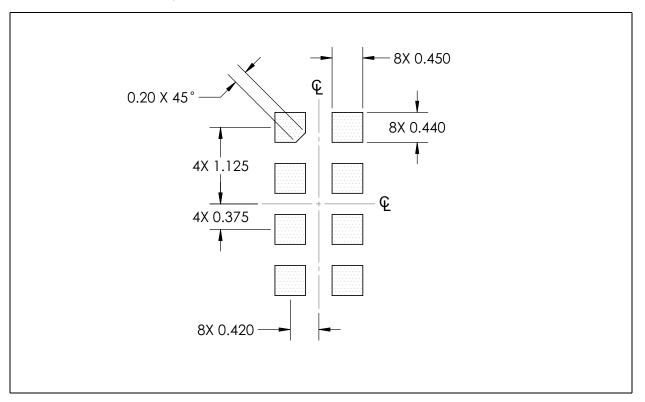
Datasheet, PublicPage 43[v2-00] 2023-Mar-14Document Feedback



PCB Pad Layout

Suggested PCB pad layout guidelines for the surface mount module are shown. Flash Gold is recommended as a surface finish for the landing pads.

Figure 69: Recommended PCB Pad Layout



Note(s):

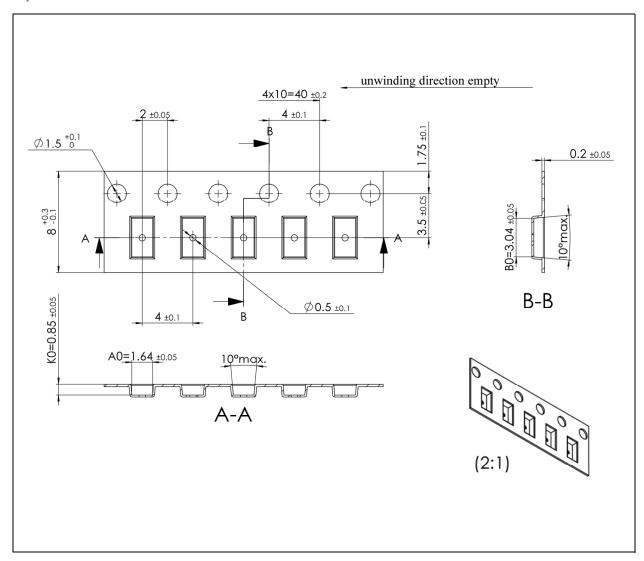
- 1. All dimensions are in millimeters.
- 2. Dimension tolerances are ± 0.05 mm unless otherwise noted.
- ${\bf 3.}\, {\bf This}\, {\bf drawing}\, {\bf is}\, {\bf subject}\, {\bf to}\, {\bf change}\, {\bf without}\, {\bf notice}.$

Page 44Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Tape & Reel Information

Figure 70: Tape & Reel Information



Note(s):

- 1. All linear dimensions are in millimeters. Dimension tolerance is ±0.10mm unless otherwise noted.
- 2. The dimensions on this drawing are for illustrative purposes only. Dimensions of an actual carrier may vary slightly.
- 3. Symbols on drawing Ao, Bo, and Ko are defined in ANSI EIA Standard 481-B 2001.
- 4. Each reel is 330mm in diameter and contains 10000 parts.
- 5. ams OSRAM packaging tape and reel conform to the requirements of EIA Standard 481-B.
- 6. In accordance with EIA standard device pin 1 is located next to the sprocket holes in the tape.
- 7. This drawing is subject to change without notice.

Datasheet, PublicPage 45[v2-00] 2023-Mar-14Document Feedback



Soldering & Storage Information

The FN package has been tested and has demonstrated an ability to be reflow soldered to a PCB substrate.

The solder reflow profile describes the expected maximum heat exposure of components during the solder reflow process of product on a PCB. Temperature is measured on top of component. The components should be limited to a maximum of three passes through this solder reflow profile.

Figure 71: Solder Reflow Profile

Profile Feature Preheat/ Soak	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Temperature Min (T _{smin})	100 °C	150 °C
Temperature Max (T _{smax})	150 °C	200 °C
Time (t_s) from $(T_{smin} to T_{smax})$	60-120 seconds	60-120 seconds
Ramp-up rate (T _L to T _P)	3 °C/second max.	3 °C/second max.
Liquidous temperature (T_L) Time (t_L) maintained above T_L	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak package body temperature (T _P)	For users T _P must not exceed the classification temp. of 235 °C For suppliers T _P must equal or exceed the classification temp of 235 °C	For users T _P must not exceed the classification temp. of 260 °C For suppliers T _P must equal or exceed the classification temp of 260 °C
Time $(t_p)^{(1)}$ within 5 °C of the specified classification temperature (T_c)	20 ⁽¹⁾ seconds	30 ⁽¹⁾ seconds
Ramp-down rate (T _P to T _L)	6 °C/second max.	6 °C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

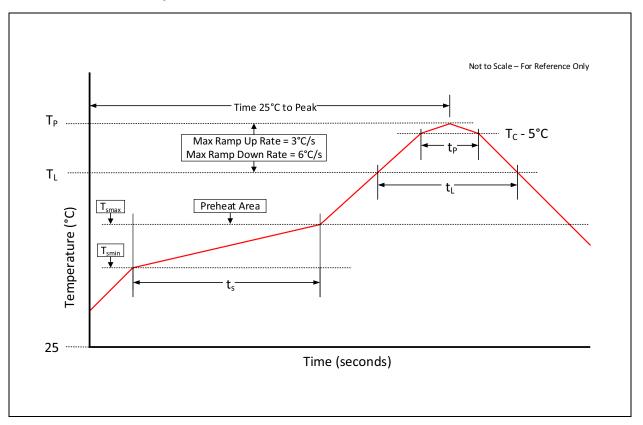
Note(s):

 $1. \, Tolerance \, for \, peak \, profile \, temperature \, (T_P) \, is \, defined \, as \, a \, supplier \, minimum \, and \, a \, user \, maximum.$

Page 46Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Figure 72: Solder Reflow Profile Graph



Storage Information

Moisture Sensitivity Optical characteristics of the device can be adversely affected during the soldering process by the release and vaporization of moisture that has been previously absorbed into the package. To ensure the package contains the smallest amount of absorbed moisture possible, each device is baked prior to being dry packed for shipping. Devices are dry packed in a sealed aluminized envelope called a moisture-barrier bag with silica gel to protect them from ambient moisture during shipping, handling, and storage before use.

Shelf Life

The calculated shelf life of the device in an unopened moisture barrier bag is 24 months from the date code on the bag when stored under the following conditions:

• Shelf Life: 24 months

• Ambient Temperature: < 40°C

• Relative Humidity: < 90%

Rebaking of the devices will be required if the devices exceed the 24 months shelf life or the Humidity Indicator Card shows that the devices were exposed to conditions beyond the allowable moisture region.

Datasheet, PublicPage 47[v2-00] 2023-Mar-14Document Feedback



Floor Life

The module has been assigned a moisture sensitivity level of MSL 3. As a result, the floor life of devices removed from the moisture barrier bag is 168 hours from the time the bag was opened, provided that the devices are stored under the following conditions:

• Floor Life: 168 hours

• Ambient Temperature: < 30°C

• Relative Humidity: < 60%

If the floor life or the temperature/humidity conditions have been exceeded, the devices must be rebaked prior to solder reflow or dry packing.

Rebaking Instructions

When the shelf life or floor life limits have been exceeded, rebake at 50°C for 12 hours.

Page 48Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Laser Eye Safety

Complies with IEC/EN 60825-1:2014 and 21 CFR 1040.10 and 1040.11 except for deviations pursuant to Laser Notice No. 50, dated June 24, 2007

The TMD3702VC is designed to meet the Class 1 laser safety limits including single faults in compliance with IEC/EN 60825-1:2014. In an end application system environment, the system may need to be tested to ensure it remains compliant. The system must not include any additional lens to concentrate the laser light or parameters set outside of the recommended operating conditions. Use outside of the recommended condition or any physical modification to the module during development could result in hazardous levels of radiation exposure.



Datasheet, PublicPage 49[v2-00] 2023-Mar-14Document Feedback



Ordering & Contact Information

Figure 73: Ordering Information

Ordering Code	I ² C Bus	I ² C Address	Delivery Form	Delivery Quantity
TMD37024VC	1.8V	0x49	Tape & Reel (13")	10000pcs/reel
TMD37024VCM	1.8V	0x49	Tape & Reel (7")	1000pcs/reel

Buy our products or get free samples online at:

www.ams.com/Products

Technical Support is available at:

www.ams.com/Technical-Support

Provide feedback about this document at:

www.ams.com/Document-Feedback

For further information and requests, e-mail us at:

ams_sales@ams.com

 $For \ sales \ of fices, \ distributors \ and \ representatives, \ please \ visit:$

www.ams.com/Contact

Headquarters

ams-OSRAM AG Tobelbader Strasse 30 8141 Premstaetten Austria, Europe

Tel: +43 (0) 3136 500 0

Website: www.ams.com

Page 50Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



RoHS Compliant & ams Green Statement

RoHS: The term RoHS compliant means that ams-OSRAM AG products fully comply with current RoHS directives. Our semiconductor products do not contain any chemicals for all 6 substance categories plus additional 4 substance categories (per amendment EU 2015/863), including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, RoHS compliant products are suitable for use in specified lead-free processes.

ams Green (RoHS compliant and no Sb/Br/Cl): ams Green defines that in addition to RoHS compliance, our products are free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material) and do not contain Chlorine (Cl not exceed 0.1% by weight in homogeneous material).

Important Information: The information provided in this statement represents ams-OSRAM AG knowledge and belief as of the date that it is provided. ams-OSRAM AG bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. ams-OSRAM AG has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. ams-OSRAM AG and ams-OSRAM AG suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

Datasheet, Public Page 51 **Document Feedback**



Copyrights & Disclaimer

Copyright ams-OSRAM AG, Tobelbader Strasse 30, 8141 Premstaetten, Austria-Europe. Trademarks Registered. All rights reserved. The material herein may not be reproduced, adapted, merged, translated, stored, or used without the prior written consent of the copyright owner.

Devices sold by ams-OSRAM AG are covered by the warranty and patent indemnification provisions appearing in its General Terms of Trade. ams-OSRAM AG makes no warranty, express, statutory, implied, or by description regarding the information set forth herein, ams-OSRAM AG reserves the right to change specifications and prices at any time and without notice. Therefore, prior to designing this product into a system, it is necessary to check with ams-OSRAM AG for current information. This product is intended for use in commercial applications. Applications requiring extended temperature range, unusual environmental requirements, or high reliability applications, such as military, medical life-support or life-sustaining equipment are specifically not recommended without additional processing by ams-OSRAM AG for each application. This product is provided by ams-OSRAM AG "AS IS" and any express or implied warranties, including, but not limited to the implied warranties of merchantability and fitness for a particular purpose are disclaimed.

ams-OSRAM AG shall not be liable to recipient or any third party for any damages, including but not limited to personal injury, property damage, loss of profits, loss of use, interruption of business or indirect, special, incidental or consequential damages, of any kind, in connection with or arising out of the furnishing, performance or use of the technical data herein. No obligation or liability to recipient or any third party shall arise or flow out of ams-OSRAM AG rendering of technical or other services.

Page 52

Document Feedback

[v2-00] 2023-Mar-14



Document Status

Document Status	Product Status	Definition
Product Preview	Pre-Development	Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice
Preliminary Datasheet	Pre-Production	Information in this datasheet is based on products in the design, validation or qualification phase of development. The performance and parameters shown in this document are preliminary without any warranty and are subject to change without notice
Datasheet	Production	Information in this datasheet is based on products in ramp-up to full production or full production which conform to specifications in accordance with the terms of ams-OSRAM AG standard warranty as given in the General Terms of Trade
Datasheet (discontinued)	Discontinued	Information in this datasheet is based on products which conform to specifications in accordance with the terms of ams-OSRAM AG standard warranty as given in the General Terms of Trade, but these products have been superseded and should not be used for new designs

Datasheet, Public Page 53 [v2-00] 2023-Mar-14 Document Feedback



Revision Information

Changes from 1-04 (2020-Apr-07) to current revision 2-00 (2023-Mar-14)	Page
Updated "Shelf Life" to 24 months	47

Note(s):

- 1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.
- $2. \ Correction \ of \ typographical \ errors \ is \ not \ explicitly \ mentioned.$

Page 54Datasheet, PublicDocument Feedback[v2-00] 2023-Mar-14



Content Guide

- 1 General Description
- 1 Key Benefits & Features
- 2 Applications
- 2 Block Diagram
- 3 Pin Assignment
- 4 Absolute Maximum Ratings
- **5** Electrical Characteristics
- 9 Typical Operating Characteristics

13 Detailed Description

- 13 Proximity
- 13 Color and Ambient Light Sense
- 13 I²C Characteristics
- 14 I²C Write Transaction
- 14 I²C Read Transaction

16 Register Description

- 18 Enable Register (Address 0x80)
- 19 ATIME Register (Address 0x81)
- 19 PRATE Register (Address 0x82)
- 20 WTIME Register (Address 0x83)
- 21 AILTL Register (Address 0x84)
- 21 AILTH Register (Address 0x85)
- 22 AIHTL Register (Address 0x86)
- 22 AIHTH Register (Address 0x87)
- 23 PILTL Register (Address 0x88)
- 23 PILTH Register (Address 0x89)
- 24 PIHTL Register (Address 0x8A)
- 24 PIHTH Register (Address 0x8B)
- 25 PERS Register (Address 0x8C)
- 26 CFG0 Register (Address 0x8D)
- 26 PCFG0 Register (Address 0x8E)
- 28 PCFG1 Register (Address 0x8F)
- 29 CFG1 Register (Address 0x90)
- 29 REVID Register (Address 0x91)
- 30 ID Register (Address 0x92)
- 30 Status Register (Address 0x93)
- 31 CDATAL Register (Address 0x94)
- 31 CDATAH Register (Address 0x95)
- 31 RDATAL Register (Address 0x96)
- 31 RDATAH Register (Address 0x97)
- 32 GDATAL Register (Address 0x98)
- 32 GDATAH Register (Address 0x99)
- 32 BDATAL Register (Address 0x9A)
- 32 BDATAH Register (Address 0x9B)
- 33 PDATAL Register (Address 0x9C)
- 33 PDATAH Register (Address 0x9D)
- 34 REVID2 Register (Address 0x9E)
- 34 CFG2 Register (Address 0x9F)
- 34 SOFTRST Register (Address 0xA0)
- 35 CFG3 Register (Address 0xAB)
- 35 CFG4 Register (Address 0xAC)
- 36 CFG6 Register (Address 0xAE)



- 36 POFFSETL Register (Address 0xC0)
- 36 POFFSETH Register (Address 0xC1)
- 37 CALIB Register (Address 0xD7)
- 38 CALIBCFG Register (Address 0xD9)
- 39 CALIBSTAT Register (Address 0xDC)
- 39 INTENAB Register (Address 0xDD)
- 40 FAC_L Register (Address 0xE6)
- 40 FAC_H Register (Address 0xE7)
- 40 TEST3 Register (Address 0xF2)
- 41 Application Information
- 43 Package Drawings & Markings
- 44 PCB Pad Layout
- 45 Tape & Reel Information
- 46 Soldering & Storage Information
- 47 Storage Information
- 47 Shelf Life
- 48 Floor Life
- 48 Rebaking Instructions
- 49 Laser Eye Safety
- 50 Ordering & Contact Information
- 51 RoHS Compliant & ams Green Statement
- 52 Copyrights & Disclaimer
- 53 Document Status
- 54 Revision Information

Page 56

Document Feedback

[v2-00] 2023-Mar-14